

Form PTO-1449 (modified)

LIST OF PRIOR ART CITED BY APPLICANT



Sheet 1 of 2

Application No.: 09/850,985
 Filing Date: May 8, 2001
 First Named Inventor: Wen Pao Wu
 Group Art Unit: 1772
 Examiner: Not Assigned
 Attorney Docket No.: 47097-01059

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U.S. PATENT DOCUMENTS

Examiner Initial	Ref.	Document Number	Date	Name	Class	Sub-Class	Filing Date (if Application)
S.M.	A1	4,244,860	01/13/1981	Kühnel et al.	260	42.15	
	A2	4,244,910	01/13/1981	Yui et al.	264	328.12	
	A3	4,461,871	07/24/1984	Kometani et al.	525	166	
	A4	4,491,553	01/01/1985	Yamada et al.	264	51	
	A5	4,524,512	06/25/1985	Formo et al.	30	147	
	A6	4,562,215	12/31/1985	Carter et al.	523	220	
	A7	4,915,611	04/10/1990	Brown	425	556	
	A8	4,948,665	08/14/1990	Rosén	428	332	
	A9	5,028,461	07/02/1991	Nakamichi	428	34.5	
	A10	5,079,287	01/07/1992	Takeshi et al.	524	528	
	A11	5,093,053	03/03/1992	Eckardt et al.	264	45.1	
	A12	5,124,193	06/23/1992	Sano et al.	428	220	
	A13	5,162,419	11/10/1992	Pottier-Metz et al.	524	451	
	A14	5,225,466	07/06/1993	Akao	524	108	
	A15	5,484,824	01/16/1996	Abe et al.	523	436	
	A16	5,539,040	07/23/1996	Rohrmann	524	425	
	A17	5,723,527	03/03/1998	Sadatoshi et al.	524	451	
	A18	5,854,328	12/29/1998	Koizumi et al.	524	451	
	A19	5,920,845	07/06/1999	Risemberg	705	1	
	A20	5,973,049	10/26/1999	Bieser et al.	524	425	
	A21	6,011,102	01/04/2000	Shimojo et al.	524	451	
	A22	6,046,264	04/04/2000	Müller et al.	524	407	
	A23	6,071,462	06/06/2000	Putsch	264	328.14	

S.M. Noh.

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*Examiner: Initial if citations considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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Sheet 2 of 2							
FOREIGN PATENT DOCUMENTS							
Examiner Initial	Ref.	Document Number	Date	Country	Class	Sub-Class	Translation Yes/No
OTHER DOCUMENTS (including author, title, date, pertinent pages, etc.)							
Examiner Initial	Ref.	Document Information					
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